

## Kick-off meeting of COST action on "Trapped Ions: Progress in Classical and Quantum Applications"



Contribution ID: 14

Type: **not specified**

### **Preliminary characterization of a surface-electrode ion trap for frequency metrology**

*Wednesday, March 6, 2019 3:45 PM (15 minutes)*

**Presenter:** LACROUTE , Clement (FEMTO-ST)